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Output polarization characteristics of a GaN microcavity diode polariton laser

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We report the steady state output polarization characteristics of GaN-based microcavity polariton lasers operated with electrical injection at room temperature. The output is unpolarized below the nonlinear threshold injection current and is linearly polarized above it with a maximum degree of polarization of ~22%. The results have been analyzed theoretically, and the calculated results are in agreement with the measured data. We have also measured the polarization-resolved output light current characteristics, wherein a distinct lowering of the non-linear threshold is observed in one device. This is interpreted in terms of spatially inhomogeneous lifting of degeneracy and polarization splitting in the microcavity.

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I. INTRODUCTION

A stable linearly polarized coherent ultraviolet (UV) or deep UV light source is required for biochemical analysis, photo-alignment of nematic liquid crystals, eye surgery, and other industrial applications [1]. A single source or an array, to get higher powers, would be adequate for such applications. Current planar GaN-based UV lasers have threshold currents ~10 kA cm$^{-2}$ or higher. A polariton laser is an inversionless coherent light source [2,3] operating in the strong coupling regime of light-matter interaction [4–6]. Exciton-polariton lasers have been realized with suitable semiconductor microcavities with both optical and electrical pumping [7–24]. Coherent emission is produced by spontaneous radiative recombination from a macroscopic, coherent, and degenerate exciton-polariton condensate, often termed a Bose–Einstein condensate or BEC [11,12,25,26]. In the case of polariton lasers, the system is in a metastable condensed state in which the polaritons are only in equilibrium among themselves and not with the semiconductor lattice. Thus, although the redistribution of polaritons in momentum space above the condensation threshold does not conform to equilibrium Bose–Einstein statistics, nevertheless the bimodal distribution of polaritons which develops above threshold have many of the properties of BECs. The nonlinear threshold of a polariton laser is lower than that of a conventional photon laser because the former does not require the inversion of electronic population, and quantum degeneracy may be reached at very low polariton densities. The bosonic behavior of the degenerate state, or polariton ground state, has been verified by several elegant experiments [3,7–26]. An important characteristic of the output of a polariton laser is its polarization [11,12,25,27–35]. Below the nonlinear threshold, the optical output is essentially unpolarized [11,12,14,21,25,32,34,35]. As the nonlinear threshold is reached, there is spontaneous buildup of linear polarization in the emission spectra, which is a consequence of spontaneous symmetry breaking in the degenerate condensate [25,28–30,33,34]. The linear polarization results from a breaking of the ground state degeneracy into two closely spaced states. Above threshold, the condensate occupies the lower of these two states, and the linear polarization of the emission corresponds to this state.

II. EXPERIMENT AND RESULTS

In all the reported experiments [3,11,12,14,25,31,34,35], except one with a GaAs-based microcavity at 30 K [21], the device has been excited with linearly or circularly polarized light. We report here an experimental study of the output polarization characteristics of a GaN-based electrically pumped microcavity polariton laser. We have studied electrically pumped bulk GaN microcavity polaritoner lasers operated at room temperature [24,36,37]. The devices are characterized by a threshold current density in the range of $J_{th} = 125–375$ A cm$^{-2}$, a detuning ranging from $-4$ to $-13$ meV, and a strong coupling in the microcavity characterized by a Rabi splitting of 33.9–35.5 meV. The formation of a degenerate condensate is observed in the angular resolved electroluminescence data. In particular, we have investigated the steady state linear polarization buildup caused by polarization pinning in the output of multiple devices. It is observed that the emission is unpolarized below the nonlinear threshold and is linearly polarized above it with a maximum polarization of ~22%. For higher injection currents, the degree of polarization decreases. It is also observed that in one device the nonlinear threshold for the linear polarization-resolved output is significantly lower than that for the unresolved output, a phenomenon which possibly indicates that the microcavity may be spatially inhomogeneous and the polarization splitting is different in different domains [38,39].

In the present paper, we have characterized several identical electrically pumped bulk GaN-based microcavity polariton lasers fabricated from a single epitaxially grown heterostructure sample shown in Fig. 1(a). Device fabrication is described...
in the Supplemental Material [40], and the device is shown schematically in Fig. 1(b). Since the device cross section is fairly small, any difference in the measured characteristics between the devices is expected to arise from the number of defects in the active region. The defect density in the active region is fairly small, any difference in the measured characteristics between the devices is expected to arise from the number of defects in the active region. The defect density in the active region is 6 × 10^8 cm^-2 [37]. All measurements reported here have been done at room temperature. The microcavity quality factor Q, and the corresponding cavity mode lifetime τ_c are determined to be ~1700 and ~0.3 ps, respectively, from room temperature microphotoluminescence measurements (see Supplemental Material [40]). The microphotoluminescence data is shown in Fig. 1(c). Angle-resolved electroluminescence measurements were made to ascertain the strong coupling regime of operation of the devices and to determine the polariton dispersion characteristics and are described in the Supplemental Material [40]. The measurements were carried out at a low value of continuous wave (CW) current injection (later confirmed to be 0.95 J_th, where J_th is the nonlinear threshold to be described later). From the analysis of the measured subthreshold lower polariton (LP) dispersion characteristics, in the framework of the 2 × 2 coupled harmonic oscillator model, the cavity-to-exciton detuning δ and vacuum field Rabi splitting Ω of two devices are found to be in the ranges of −4 to −13 meV and 33.9–35.5 meV, respectively. The dispersion curves are calculated assuming the exciton linewidth of 6 meV. In the following, the polariton lasing features are described in more detail.

The output light-current (L-I) characteristics of the devices were determined by recording the electroluminescence in the direction normal (k_∥ ∼ 0) to the Bragg mirrors (zero angle) as a function of continuous wave injection current. The LP emission intensities were recorded by a photomultiplier tube after spectrally filtering the output luminescence through an imaging monochromator. The output power was also directly measured with an optical power meter at sufficiently high injections above threshold. Both techniques yielded identical trends. As shown in Fig. 2(a), a nonlinear threshold signaling the onset of stimulated scattering is observed at a current density of J_th = 262.5 A cm^-2, which is close to the value reported previously in similar devices [24,36,37]. The corresponding LP density at threshold is 3.88 × 10^{16} cm^-3, calculated with an excitonic radiative recombination lifetime of 0.71 ns. The nonlinear region of the electroluminescence is characterized by a slope of ~13.7, and the enhancement of the output coherent luminescence over the active lasing regime is ~3.5 orders of magnitude. Both values are comparable to the corresponding characteristics of the best optically pumped CdTe-based, GaAs-based, and GaN-based polariton lasers reported in the literature [3,7–9,11–15,20] and are significantly better than those reported for electrically pumped devices [21,22,24,36,37]. The onset of nonlinearity and threshold are accompanied by an abrupt reduction of the LP emission linewidth and a blue shift of the LP electroluminescence peak energy (~0.2 meV) shown in Figs. 2(b) and 2(c), respectively. The minimum measured emission linewidth is ~870 μeV, which corresponds to a LP coherence time of ~4.8 ps. The spontaneous radiative recombination lifetime of the lower polaritons in the condensate is estimated as τ_c = τ_c/|C(k_∥ = 0)|^2 = 0.6 ps. With further increase of the injection current, the transition from strong coupling to weak coupling takes place, and at J = 36.8 kA cm^-2, conventional photon lasing due to population inversion is observed. The two-threshold lasing behavior is shown in Fig. 2(d). The polariton occupation in momentum space at different injection levels was also measured by angle-resolved electroluminescence in several devices. The occupation is calculated from the output power measured with an optical power meter after spectrally filtering the part of the electroluminescence spectrum centered on the lower polariton resonances. The polariton occupation number per k_∥ state is calculated using the relation,

\[ \tau_c \sim 1700 \]


\[ I_{Lp} = \eta \frac{n_{\text{rad}}(\mathbf{k}) \langle C(k_{\parallel}) \rangle^2 M_{\text{hc}}}{\tau_{\text{rc}}} \]

where \( \eta \) is the collection efficiency, \( \tau_{\text{rc}} \) is the spontaneous radiative recombination lifetime of the lower polaritons, \( M \) is the number of transverse states included in the detection cone, and \( \langle C(k_{\parallel}) \rangle^2 \) is the photon fraction at wave vector \( k_{\parallel} \). The number of states within the detection cone is given by \( M = D^2/16k_0\Delta \), where \( D \) is the diameter of the emission spot, \( k_0 = 2\pi/\lambda \) (the free space wave number), and \( \Delta \) is the detection half angle. The polariton condensate occupation numbers are very similar in all the devices. Representative data are shown in Fig. 2(e). A random and nonthermal LP occupation below threshold transforms to a peaked occupancy at \( k_{\parallel} \sim 0 \) above threshold, signaling the formation of a coherent bosonic condensate. There is no evidence of a relaxation bottleneck at any injection [24,36,37].

We measured the degree of linear polarization of the polariton emission in the normal direction (\( k_{\parallel} \sim 0 \)) (see Supplemental Material [40]) as a function of injection current in multiple devices. Figure 3(a) is a plot of the electroluminescence intensity as a function of the angle of the linear analyzer. Below the nonlinear threshold, the emission is depolarized. Above threshold, a maximum linear polarization of \( \sim 22\% \) is recorded for an injection level of 275 A cm\(^{-2} \). The linear polarization is found to be preferentially oriented along the [100] crystallographic axis in all the devices. Figures 3(b) and 3(c) depict the measured steady state linear polarization of the output LP electroluminescence as a function of the injection current for two devices. The output is essentially unpolarized below the threshold value, the degree of linear polarization being below the detection limit of the measurement system. At threshold, there is a sharp increase in linear polarization due to stimulated LP scattering from the unpolarized reservoir to the polarized seed condensate in the presence of a small linear polarization splitting [38]. This is followed by a peaking and a steady decrease at higher injection, which is the depinning effect also observed by Levrat et al. [34]. The depinning effect is a result of strong polariton-polariton repulsive interactions and self-induced Larmor precession of the Stokes vector of the condensate [33,34]. The measured thresholds for linear polarization agree with the nonlinear threshold in the light-current characteristics within the limits of experimental accuracy. Polarization-resolved light-current characteristics were also measured and are plotted alongside the polarization integrated characteristics for two devices in Figs. 3(d) and 3(e). The data of device 2 in Fig. 3(e) indicate that the value of the threshold current density remains unchanged for the two cases within the experimental accuracy. In contrast, similar data for device 1 shown in Fig. 3(d) indicate a reduction of the threshold current density of the polarization-resolved output by \( \sim 70 \) A cm\(^{-2} \) compared with that of the polarization unresolved output, as one can clearly see in the inset. This effect was only observed in one device, nonetheless, during repeated measurements. It may be remembered that this device also exhibited the highest degree of nonlinearity and strong coupling over a wide injection range. The lower threshold of a specific linear polarization-resolved electroluminescence probably results from a spatially inhomogeneous polarization splitting in the GaN microcavity, similar to what has been observed before in a CdTe microcavity [38,39]. Some parts of the sample may be characterized by a large splitting of the linearly polarized modes and a specific linear polarization buildup occurs with a lower threshold. In other domains the polarization splitting is negligibly small, resulting in emission which will be unpolarized in the steady state. The lowering of threshold observed here is less than the expected factor of 2 due to deviations in the microcavity characteristics from an ideal case. Nonetheless, this is the manifestation of inhomogeneity, probably arising from defects, in the linear polarization-resolved electroluminescence of a polariton laser. Similar, albeit not identical, results have been observed in InGaAs microcavities, under nonresonant, circularly polarized, optical pulsed excitation, where the transition from the strong to the weak coupling regime takes place with increasing excitation at different powers for polaritons with opposite spin polarizations and is determined by the relative populations of the polaritons with opposite spin orientations [41,42].
FIG. 3. (a) Polar plots of the normal incidence \( (k_\parallel \sim 0) \) LP electroluminescence intensities recorded as a function of angle of linear analyzer below and above threshold of device 1. (The single error bar shown in this figure is common to all the corresponding data points). (b) and (c) Measured steady-state degree of linear polarization of device 1 and device 2, respectively, as a function of injected current density. The solid line represents the theoretically calculated values. (d) Polarization-resolved (along 90° angle of the linear analyzer) and unresolved light-current characteristics of device 1. The inset shows an enlargement highlighting the different thresholds. (e) Polarization-resolved (along 90° angle of the linear analyzer) and unresolved light-current characteristics of device 2.

III. ANALYSIS AND DISCUSSIONS

We have analyzed the experimental results by modeling the kinetics of the system with the four coupled stochastic differential equations [33,34].

\[
\frac{d\psi_\sigma}{dt} = \frac{1}{2}[W(t) - \Gamma_c]\psi_\sigma + \frac{1}{2}(\gamma + i\Omega)\psi_{-\sigma} - \frac{i}{\hbar}[\alpha_1|\psi_\sigma|^2 + \alpha_2|\psi_{-\sigma}|^2]|\psi_\sigma + \theta_\sigma(t) \tag{1}
\]

\[
W(t) = a_{ph}N_e(t) + b_{pol}N_e^2(t) \tag{2}
\]

\[
\frac{dN_e}{dt} = -\Gamma_cN_e - W(t)[|\psi_-|^2 + |\psi_+|^2 + 1] + W_c n_{e-h}(t) \tag{3}
\]

\[
\frac{dn_{e-h}}{dt} = J - \frac{n_{e-h}}{\tau_{e-h}} - W_c n_{e-h} \tag{4}
\]

The order parameter \( \psi_\pm \) describes the many-body wavefunction of polariton condensates with +1 and −1 projections of spin to the structure axis, \( N_e \) is the exciton reservoir occupation, and \( n_{e-h} \) is the occupation of the free carrier reservoir. \( W(t) \) defines the rate of the polariton relaxation towards the ground state. We consider two relaxation mechanisms, namely the polariton-phonon scattering characterized by the scattering rate \( a_{ph} \) and polariton-polariton scattering with the rate \( b_{pol} \). In all probability, the phonon scattering process [the first term on the right-hand side of Eq. (2)] does not involve a single scattering event but rather proceeds through a cascade of phonon emissions. Nevertheless, the phenomenon of final state occupation is present, and for the rate of polariton-polariton scattering, it is proportional to the square of the reservoir occupation as the rate of any two-body collision process. The first term in the right-hand side of Eq. (2) describes the phonon-induced scattering of excitons and is linearly dependent on the exciton reservoir occupation. The two-body collision process is described by the second term in Eq. (2), which is quadratic in the exciton reservoir occupation. \( \Gamma_c \) is inversely proportional to the polariton lifetime, which is mainly governed by the cavity quality factor. The constants \( \Omega \) and \( \gamma \) correspond to the effective magnetic field leading to the energy splitting of the polarized condensate states and to the spin relaxation term, respectively. Constants \( \alpha_1 \) and \( \alpha_2 \) describe the interactions of polaritons with the same and opposite spin. 

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projections, respectively. Phenomenological constants $\Gamma_e$ and $W_e$ describe the decay rate of the excitons in the reservoir and the exciton formation rate, respectively.

The noise term $\theta(t)$ is defined by its correlators:

$$\langle \theta_\sigma(t)\theta_\sigma(t') \rangle = 0 \tag{5}$$

$$\langle \theta_\sigma(t)\theta_\sigma(t') \rangle = \frac{1}{2} W(t)\delta_\sigma\delta(t-t') \tag{6}$$

The system of Eqs. (1)–(4) is then numerically solved using the stochastic Runge–Kutta algorithm. For the numerical calculation we use the following parameters corresponding to conventional GaN-based laser diodes [43]: $\Gamma_e = 1.3\text{ ps}^{-1}$, $\gamma = 0.0035\text{ ps}^{-1}$, $\Omega = 0.03\text{ ps}^{-1}$, $\alpha_1 = 0.0001\text{ ps}^{-1}$, $\alpha_2 = -0.1a_1, \alpha_{ph} = 10^{-11}\text{ ps}^{-1}$, $b_{pol} = 10^{-12}\text{ ps}^{-1}$, $\Gamma_r = 0.001\text{ ps}^{-1}$, $W_e = 0.01\text{ ps}^{-1}$, $\tau_{e-h} = 2000\text{ ps}$. The ground state occupation number is given by $n(t) = |\psi_+|^2 + |\psi_-|^2$, and the components of the condensate pseudospin linked to the output light polarization are:

$$S_x = \text{Re}(\psi_+^*\psi_-) \tag{7}$$

$$S_y = \text{Im}(\psi_+^*\psi_-) \tag{8}$$

$$S_z = \frac{1}{2}(|\psi_+|^2 - |\psi_-|^2) \tag{9}$$

Time- and noise-averaged signals have been recorded during the measurements. Namely, the degree of linear polarization is given by $s_x = \langle \int dt \hat{S}_x(t) / \int dt n(t) \rangle$, where brackets symbolize averaging over the noise. We next compare the results of the experimental and numerical simulations. Figure 2(a) shows the calculated dependence of the condensate occupation number $n(t)$ on the injected current density alongside the measured data. Figure 3(b) shows the calculated dependence of the degree of linear polarization of the polariton laser emission on the pump current together with the measured data for device 1. In order to obtain the theoretical values of the degree of linear polarization for device 2, the following parameters have been varied with respect to the analysis for device 1: the spin relaxation rate $\gamma$ has been changed from 0.0035 to 0.005 ps$^{-1}$, the polariton radiative rate $\Gamma_e$ has been changed from 1.3 to 1 ps$^{-1}$, and the internal magnetic field $\Omega$ has been changed from 0.03 to 0.05 ps$^{-1}$. Figure 3(c) shows the calculated and measured dependence of the degree of linear polarization of the polariton laser emission on the pump current for device 2. We observe that the calculated linear polarization shows good agreement with the measured data, in general. One can see that the difference in current density dependence of the linear polarization between devices 1 and 2 is chiefly due to the different spin relaxation and polariton radiative decay rates. The spin relaxation rate and the polariton radiative decay rate is $\sim30\%$ faster and $\sim30\%$ slower, respectively, in device 2 compared with device 1.

We ascribe these differences to the different magnitudes of photonic disorder in the two devices. The value of the peak polarization is $\sim22\%$ for both devices and is governed by the ratio of the polarization relaxation rate $\gamma$ and the polariton radiative decay rate $\Gamma_r$. The lower this ratio, the shorter the time the polariton condensate possesses for relaxation to the lowest energy polarization state. We observe that this ratio, and thus the degree of peak polarization, is lower than that reported by Levrat et al. [34]. The rate of the decrease of the linear polarization beyond the peak depends on the ratio of the nonlinear coefficient $\alpha_1$ and the linear polarization splitting $\Omega$.

The spatial coherence of the polariton laser emission was measured with a misaligned Mach–Zehnder interferometer (see Supplemental Material [40]). The visibility of the fringes was measured as a function of displacement between two identical images of polariton emission for injection levels below and above the lasing threshold. The measured visibility is plotted as a function of the injection current in Fig. 4(a). A peak visibility of $\sim38\%$ is recorded above threshold at an injected current density of $J = 1.3J_\text{th}$. While the peak visibility should ideally approach unity at zero displacement between two identical images of the polariton condensate, such high values have not been reported experimentally, probably

![Figure 4](image-url)
due to quantum fluctuations in the condensate and the fact that the condensate fraction of the polariton gas should be less than 50%, which has been theoretically predicted [44]. The visibility of the fringes is plotted in Fig. 4(b) as a function of displacement between two identical images of the LP emission for injection levels below and above the polariton lasing threshold. The full width at half maximum (FWHM) of the distribution above threshold is ∼4 μm, which is the approximate size of the relevant condensate.

IV. CONCLUSIONS

In conclusion, we report on detailed steady state measurements of the linear polarization degree of electroluminescence in several diode polariton lasers. The linear polarization buildup is caused by the pinning effect that arises due to the energy splitting of polariton modes polarized along different crystal axes. In addition to the injection-dependent linear polarization, we have also studied the polarization-resolved output light-current characteristics. A maximum degree of linear polarization of ∼22% is observed. The experimental results have been theoretically analyzed by modeling the kinetics of the system with a system of coupled stochastic differential equations. The agreement of theory and experiment is very good, in general. In one of the devices, a surprising and significant lowering of the laser threshold is observed for the polarization-resolved output, compared with that for the unresolved output. This effect is believed to be induced by the spatial inhomogeneity in the microcavity due to defects or photonic disorder.

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